1st TCT Workshop

Report of Contributions

Introduction

Contribution ID: 0 Type: not specified

Introduction

Contribution ID: 1 Type: not specified

Dinner at Mamma Mia

Monday 5 October 2015 19:30 (2 hours)

Barnerstraße 42, 22765 Hamburg

Contribution ID: 2 Type: not specified

Introduction to TCT and edge-TCT workshop

Monday 5 October 2015 13:35 (15 minutes)

Presenters: KUEHN, Susanne (University of Freiburg); KUEHN, Susanne (Univ. Freiburg)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 3 Type: not specified

Hardware description: Particulars system

Monday 5 October 2015 13:50 (20 minutes)

 $Hardware\ description:\ Particulars\dots$

Setup components, general hardware description, laser monitoring

Presenters: KRAMBERGER, Gregor (Jozef Stefan Institute); ZAVRTANIK, Marko (Jozef Stefan

Institute)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 4 Type: **not specified**

PCBs and mounts for different sensors: diode, strip sensors, CMOS

Monday 5 October 2015 14:30 (10 minutes)

Presenter: Dr JANSEN, Hendrik (DESY)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 5 Type: **not specified**

Discussion and Questions

Contribution ID: 6 Type: **not specified**

Cabling, DAQ and software operation of particulars system

Monday 5 October 2015 16:00 (1 hour)

Session Classification: Lab session: DAQ&focus for preparation of scans and sensor preparation

Contribution ID: 7 Type: **not specified**

Sensor preparation

Monday 5 October 2015 17:00 (1 hour)

Session Classification: Lab session: DAQ&focus for preparation of scans and sensor preparation

Contribution ID: 8 Type: **not specified**

Theoretical background for measurements

Tuesday 6 October 2015 09:00 (20 minutes)

Presenters: KRAMBERGER, Gregor (Jozef Stefan Institute); ZAVRTANIK, Marko (Jozef Stefan

Institute)

Session Classification: Theoretical background of measurements and analysis software

Contribution ID: 9 Type: not specified

Discussion and Questions

Tuesday 6 October 2015 09:20 (10 minutes)

Session Classification: Theoretical background of measurements and analysis software

Contribution ID: 10 Type: not specified

Common code

Tuesday 6 October 2015 10:25 (20 minutes)

Presenter: Dr JANSEN, Hendrik (DESY)

Session Classification: Theoretical background of measurements and analysis software

Contribution ID: 11 Type: not specified

Measurement of edge pulse

Contribution ID: 12 Type: not specified

Readout board: DRS, Oscilloscope

Contribution ID: 13 Type: not specified

Temperature stability: PID controller

 $Temperature\ stability:\ PID\ controller$

Contribution ID: 14 Type: not specified

Measurement of edge pulse

Tuesday 6 October 2015 11:00 (30 minutes)

Session Classification: Lab session: Readout boards and temperature control

Contribution ID: 15 Type: not specified

Readout board: DRS, Oscilloscope

Tuesday 6 October 2015 11:30 (30 minutes)

Session Classification: Lab session: Readout boards and temperature control

Contribution ID: 16 Type: not specified

Temperature control and stability: PID controller

Tuesday 6 October 2015 12:00 (30 minutes)

Session Classification: Lab session: Readout boards and temperature control

Contribution ID: 17 Type: not specified

Do's and Don'ts

Tuesday 6 October 2015 14:00 (20 minutes)

Presenter: Mr WONSAK, Sven (University of Liverpool)

Session Classification: Discussion

Contribution ID: 18 Type: not specified

Discussion & Questions

Tuesday 6 October 2015 14:20 (20 minutes)

Discussion on common code, what's missing, etc.

Session Classification: Discussion

Contribution ID: 19 Type: not specified

Harware description: CERN system

Monday 5 October 2015 14:10 (20 minutes)

Harware description: CERN system

Presenter: GALLRAPP, Christian (CERN)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 20 Type: not specified

Discussion on setups

Monday 5 October 2015 14:40 (15 minutes)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 21 Type: not specified

Sensor preparation for edge, backside illumination

Monday 5 October 2015 14:55 (10 minutes)

Presenter: WONSAK, Sven (University of Liverpool)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 22 Type: not specified

DAQ + **Software operation for particulars**

Monday 5 October 2015 15:05 (15 minutes)

Presenter: KRAMBERGER, Gregor (Jozef Stefan Institute)

Session Classification: Introduction to setup and preparation of measurements

Contribution ID: 23 Type: not specified

Introduction to finding of focus

Monday 5 October 2015 15:20 (10 minutes)

Presenters: KRAMBERGER, Gregor (Jozef Stefan Institute); Dr JANSEN, Hendrik (DESY)

Session Classification: Introduction to setup and preparation of measurements

Welcome

Contribution ID: 24 Type: not specified

Welcome

Monday 5 October 2015 13:30 (5 minutes)

Presenter: Dr JANSEN, Hendrik (DESY)

Session Classification: Welcome

Contribution ID: 25 Type: not specified

Simulation from Torino

Tuesday 6 October 2015 09:30 (20 minutes)

Presenter: CARTIGLIA, Nicolo (University of Turin and INFN)

Session Classification: Theoretical background of measurements and analysis software

Contribution ID: 26 Type: not specified

Simulation from Ljubljana

Tuesday 6 October 2015 09:50 (20 minutes)

Presenters: KRAMBERGER, Gregor (Jozef Stefan Institute); ZAVRTANIK, Marko (Jozef Stefan

Institute)

Session Classification: Theoretical background of measurements and analysis software

Contribution ID: 27 Type: not specified

Discussion on common code development

Tuesday 6 October 2015 14:40 (20 minutes)

Presenter: Dr JANSEN, Hendrik (DESY)

Session Classification: Discussion

Contribution ID: 28 Type: not specified

Laser monitoring

Presenter: KRAMBERGER, Gregor (Jozef Stefan Institute)

Contribution ID: 29 Type: not specified

Simulation with TRACS

Tuesday 6 October 2015 10:10 (15 minutes)

Presenter: FERNANDES GARCIA, Marcos

Session Classification: Theoretical background of measurements and analysis software